

SPECIFICATION FOR APPROVAL

CUSTOMER: _____

CUSTOMER'S P/N : _____

PART NUMBER : WAN3216F245C0XDESCRIPTION : Chip Antenna 3216 L Ant 2.45G Type 02,04,06VERSION : V3.1ISSUE DATE : 2016/04/09

| |
|----------------------|
| CUSTOMER APPROVED |
| |

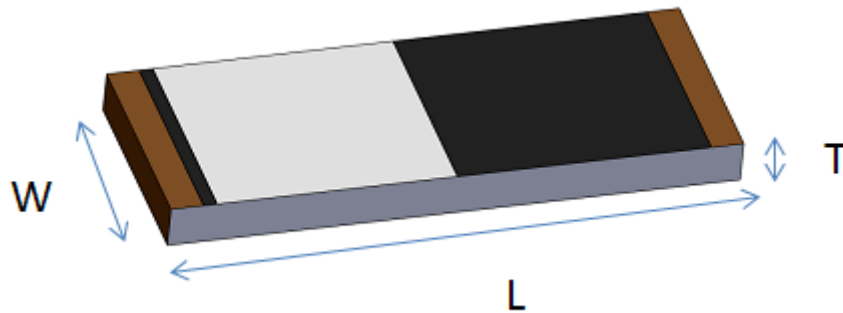
| R&D CENTER | | |
|---------------|---------|-------|
| APPROVAL | CHECKED | DRAWN |
| Ray | James | Thor |

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3216 Chip antenna

For Bluetooth / WLAN Applications



P/N: WAN3216F245C02
 WAN3216F245C04
 WAN3216F245C06

| | Dimension (mm) |
|----------|----------------|
| L | 3.23 ± 0.20 |
| W | 1.66 ± 0.20 |
| T | 0.45 ± 0.20 |

Part Number Information

WAN 3216 F 245 C 0X
 A B C D E F

| | | |
|---|-------------------|-----------------------------|
| A | Product Series | Antenna |
| B | Dimension L x W | 3.2X1.6mm (+-0.2mm) |
| C | Material | High K material |
| D | Working Frequency | 2.4 ~ 2.5GHz |
| E | Feeding mode | PIFA & Single Feeding |
| F | Antenna type | 0X=02,04,06 / Type=02,04,06 |

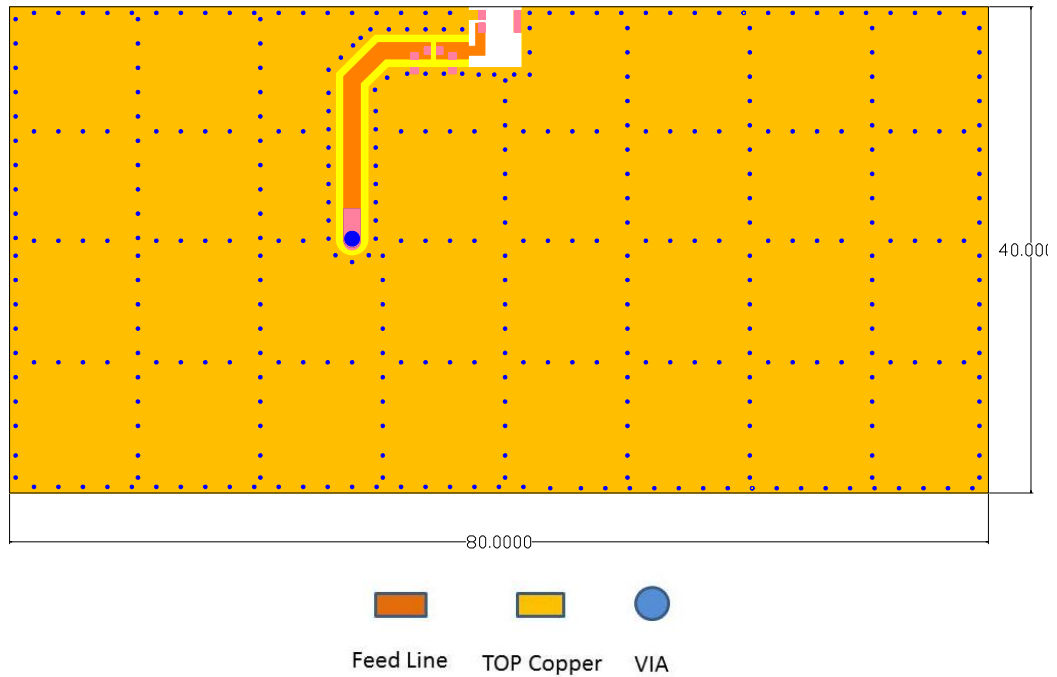
1. Electrical Specification

| Specification | | |
|-------------------------------|--|------|
| Part Number | WAN3216F245C02 WAN3216F245C04 WAN3216F245C06 | |
| Central Frequency | 2450 | MHz |
| Bandwidth | 120 (Min.) | MHz |
| Return Loss | -6.5 (Max) | dB |
| Peak Gain | 1.05 | dBi |
| Impedance | 50 | Ohm |
| Operating Temperature | -40 ~ +85 | °C |
| Maximum Power | 4 | W |
| Resistance to Soldering Heats | 10 (@ 260°C) | sec. |
| Polarization | Linear | |
| Azimuth Beamwidth | Omni-directional | |
| Termination | Ni / Au (Leadless) | |

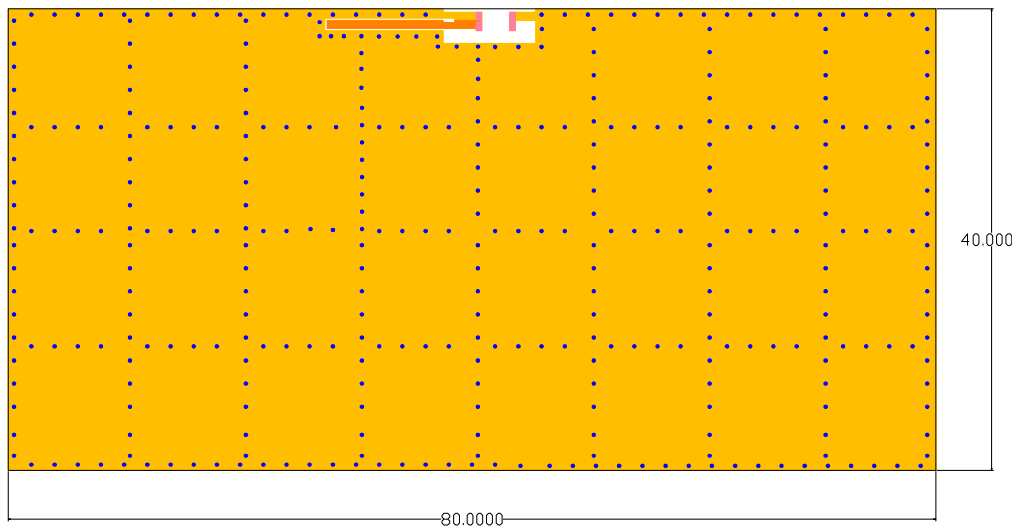
Remark : Bandwidth & Peak Gain was measured under evaluation board of next page

2. Recommended PCB Pattern

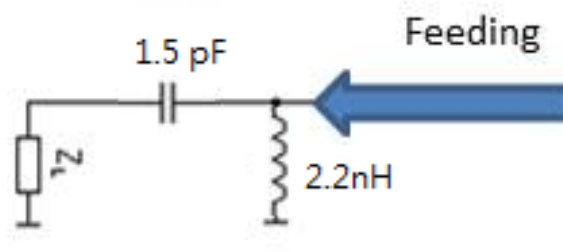
Evaluation Board Dimension



◆ 2nd Evaluation Board Dimension

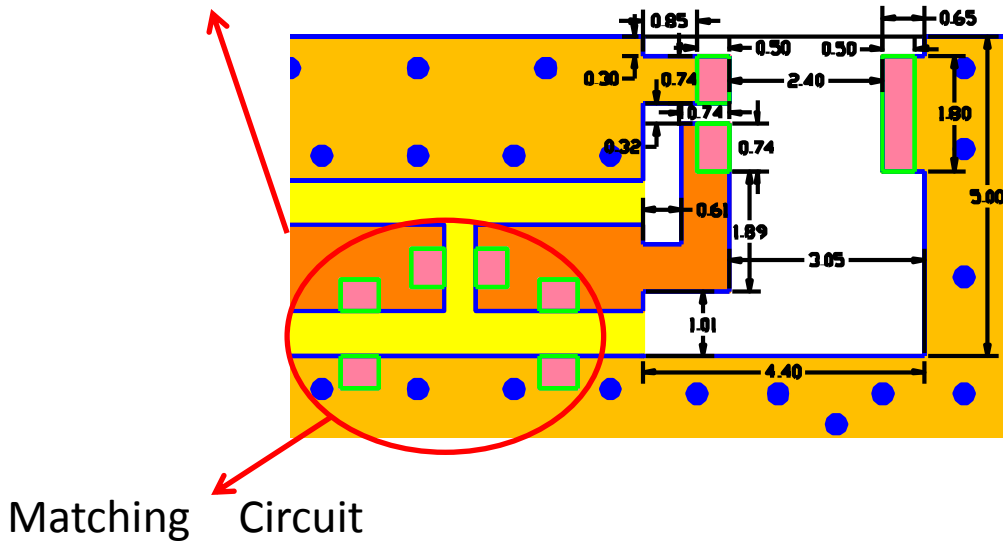


Suggested Matching Circuit

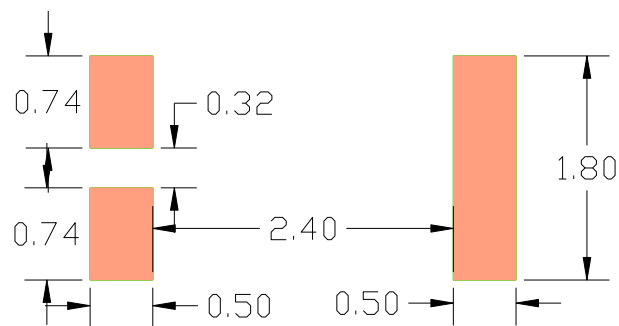


Layout Dimensions in Clearance area(Size=4.40*5.0mm)

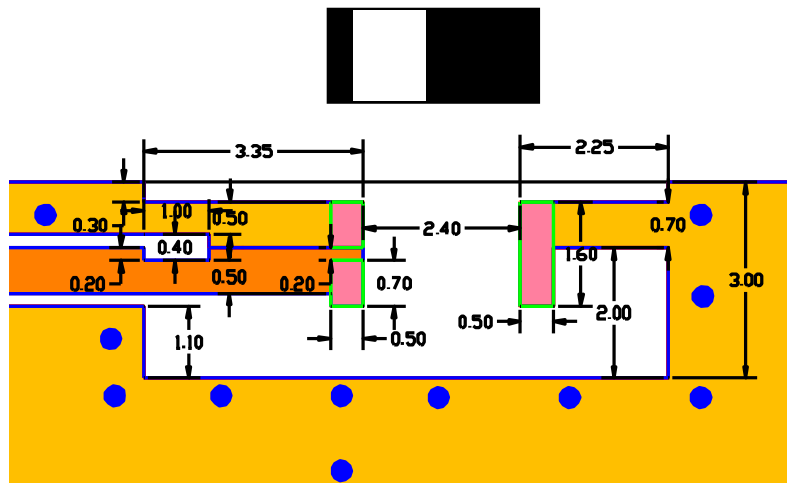
50 ohm transmission Line



FootPrint (Unit : mm)

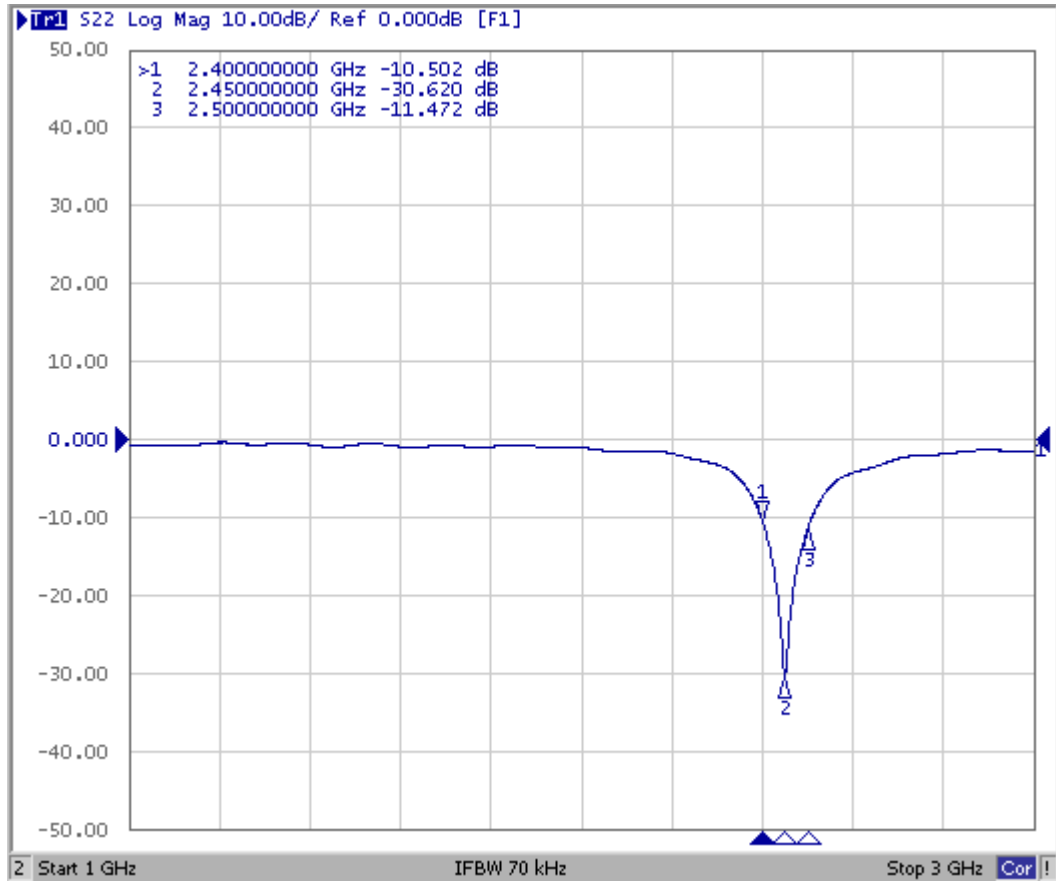


◆ 2nd Layout Dimensions in Clearance area(Size=8.0*3.0mm)

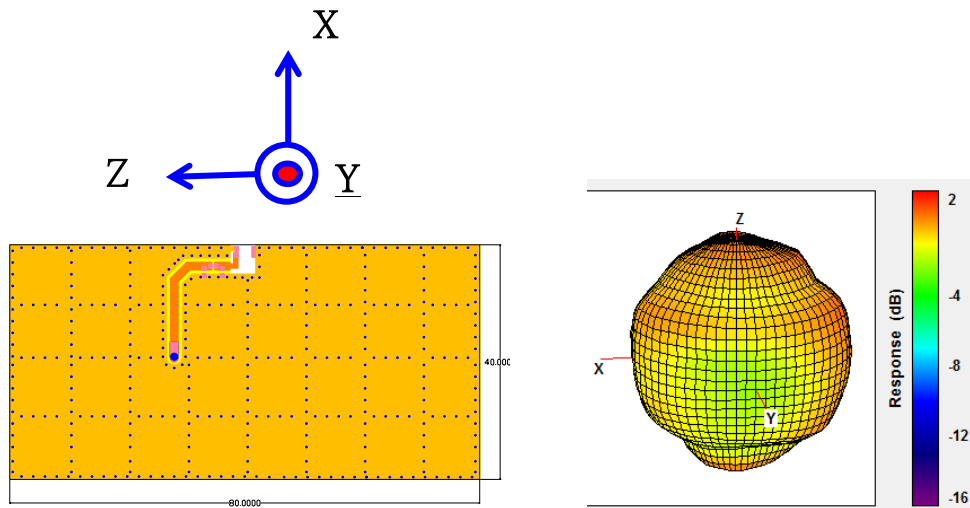


3. Measurement Results

Return Loss

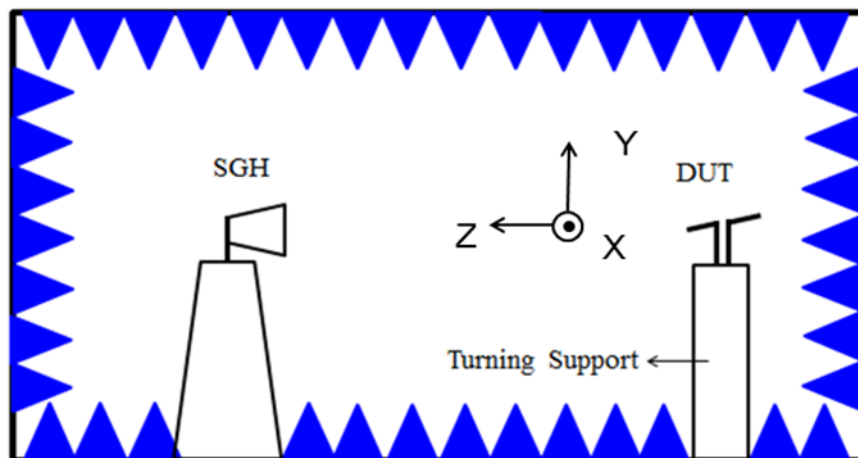


Radiation Pattern

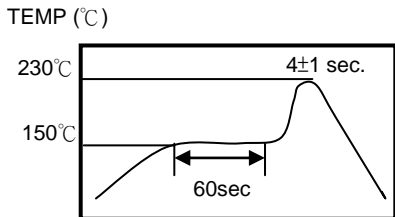
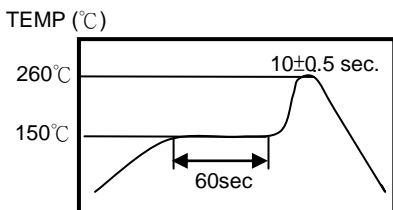


| | Efficiency | Peak Gain | Directivity |
|---------|------------|-----------|-------------|
| 2450MHz | 76.65% | 1.05 dBi | 2.69 dBi |

Chamber Coordinate System

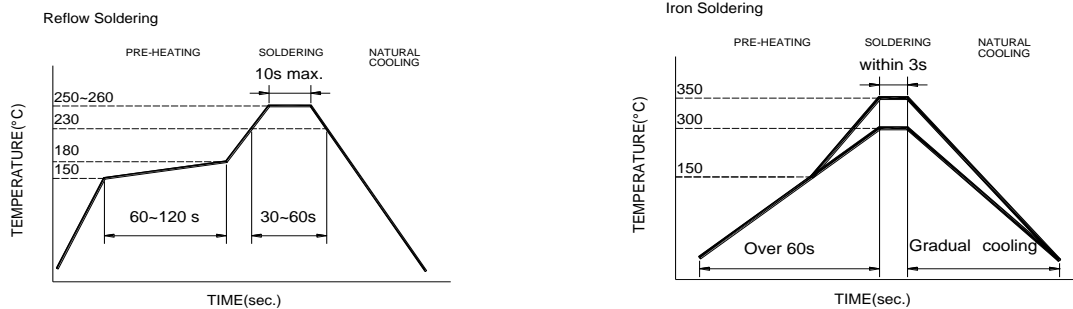


4. Reliability and Test Conditions

| ITEM | REQUIREMENTS | TEST CONDITION | | | | | | | | | | | | | | | |
|--------------------------------|--|---|-----------------|-----------|---|---------|------|---|------------------|-------------|---|---------|------|---|------------------|-------------|---|
| Solderability | 1. Wetting shall exceed 90% coverage 2. No visible mechanical damage  | Pre-heating temperature: 150°C / 60sec. Solder temperature: 230±5°C Duration: 4±1sec. Solder: Sn-Ag3.0-Cu0.5 Flux for lead free: rosin | | | | | | | | | | | | | | | |
| Solder heat Resistance | 1. No visible mechanical damage 2. Central Freq. change :within ± 6%  | Pre-heating temperature: 150°C / 60sec. Solder temperature: 260±5°C Duration: 10±0.5sec. Solder: Sn-Ag3.0-Cu0.5 Flux for lead free: rosin | | | | | | | | | | | | | | | |
| Component Adhesion (Push test) | 1. No visible mechanical damage | The device should be reflow soldered (230±5°C for 10sec.) to a tinned copper substrate. A dynamometer force gauge should be applied to the side of the component. The device must withstand ST-F 0.5 Kg without failure of the termination attached to component. | | | | | | | | | | | | | | | |
| Component Adhesion (Pull test) | 1. No visible mechanical damage | Insert 10cm wire into the remaining open eye bend, the ends of even wire lengths upward and wind together. Terminal shall not be remarkably damaged. | | | | | | | | | | | | | | | |
| Thermal shock | 1. No visible mechanical damage 2. Central Freq. change :within ±6% <table border="1" data-bbox="360 1279 788 1532"> <thead> <tr> <th>Phase</th><th>Temperature(°C)</th><th>Time(min)</th></tr> </thead> <tbody> <tr> <td>1</td><td>+85±5°C</td><td>30±3</td></tr> <tr> <td>2</td><td>Room Temperature</td><td>Within 3sec</td></tr> <tr> <td>3</td><td>-40±2°C</td><td>30±3</td></tr> <tr> <td>4</td><td>Room Temperature</td><td>Within 3sec</td></tr> </tbody> </table> | Phase | Temperature(°C) | Time(min) | 1 | +85±5°C | 30±3 | 2 | Room Temperature | Within 3sec | 3 | -40±2°C | 30±3 | 4 | Room Temperature | Within 3sec | +85°C => 30±3min -40°C => 30±3min Test cycle: 10 cycles The chip shall be stabilized at normal condition for 2~3 hours before measuring. |
| Phase | Temperature(°C) | Time(min) | | | | | | | | | | | | | | | |
| 1 | +85±5°C | 30±3 | | | | | | | | | | | | | | | |
| 2 | Room Temperature | Within 3sec | | | | | | | | | | | | | | | |
| 3 | -40±2°C | 30±3 | | | | | | | | | | | | | | | |
| 4 | Room Temperature | Within 3sec | | | | | | | | | | | | | | | |
| Resistance to High Temperature | 1. No visible mechanical damage 2. Central Freq. change :within ±6% 3. No disconnection or short circuit. | Temperature: 85±5°C Duration: 1000±12hrs The chip shall be stabilized at normal condition for 2~3 hours before measuring. | | | | | | | | | | | | | | | |
| Resistance to Low Temperature | 1. No visible mechanical damage 2. Central Freq. change :within ±6% 3. No disconnection or short circuit. | Temperature: -40±5°C Duration: 1000±12hrs The chip shall be stabilized at normal condition for 2~3 hours before measuring. | | | | | | | | | | | | | | | |
| Humidity | 1. No visible mechanical damage 2. Central Freq. change :within ±6% 3. No disconnection or short circuit. | Temperature: 40±2°C Humidity: 90% to 95% RH Duration: 1000±12hrs The chip shall be stabilized at normal condition for 2~3 hours before measuring. | | | | | | | | | | | | | | | |

5.Soldering and Mounting

Mildly activated rosin fluxes are preferred. The minimum amount of solder can lead to damage from the stresses caused by the difference in coefficients of expansion between solder, chip and substrate. The terminations are suitable for all wave and re-flow soldering systems. If hand soldering cannot be avoided, the preferred technique is the utilization of hot air soldering tools.



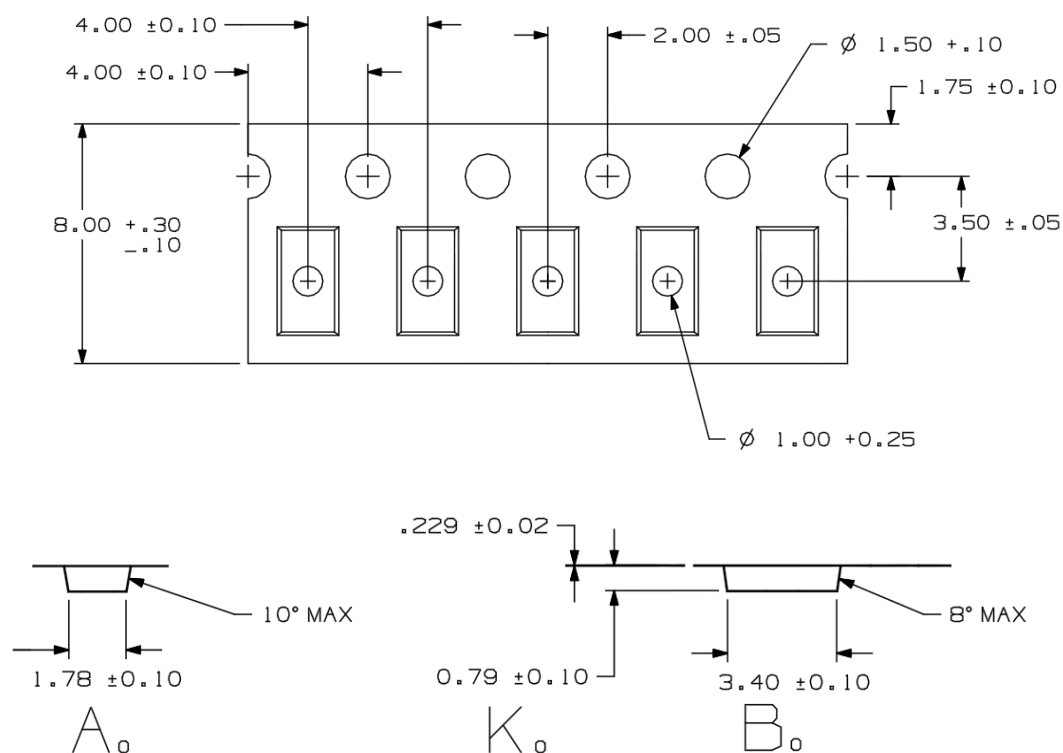
Recommended temperature profiles for re-flow soldering in Figure 1.

Products attachment with a soldering iron is discouraged due to the inherent process control limitations. In the event that a soldering iron must be employed the following precautions are recommended.

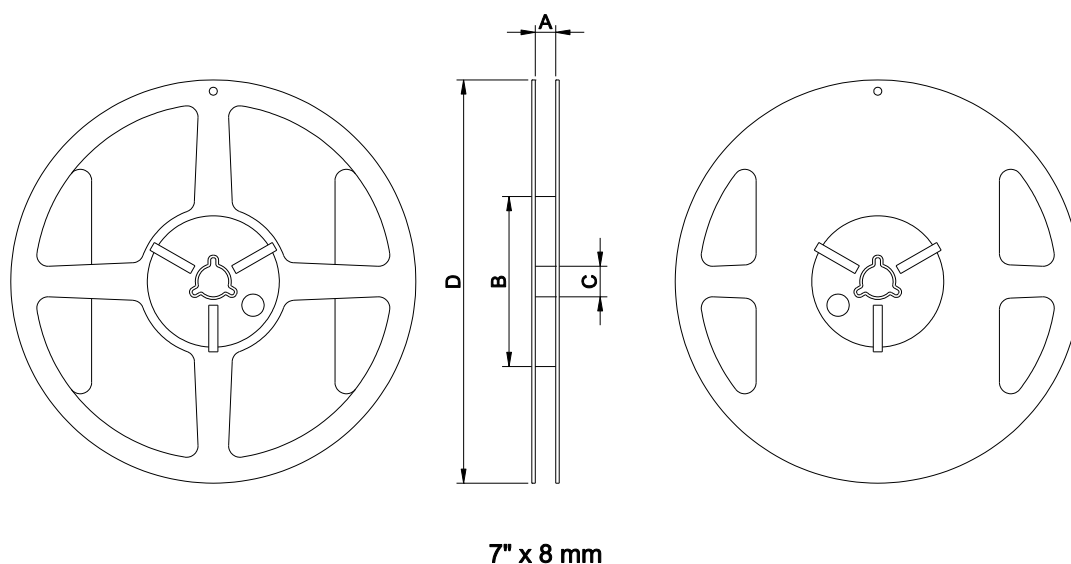
- Preheat circuit and products to 150°C
- Never contact the ceramic with the iron tip
- Use a 20 watt soldering iron with tip diameter of 1.0mm
- 280°C tip temperature (max)
- 1.0mm tip diameter (max)
- Limit soldering time to 3 sec.

6. Packaging Information

Tape Specification:



Reel Specification: (7", $\Phi 180$ mm)



| Tape Width(mm) | A(mm) | B(mm) | C(mm) | D(mm) | Chip/Reel(pcs) |
|----------------|---------------|------------|----------------|-------------|----------------|
| 8 | 9.0 ± 0.5 | 60 ± 2 | 13.5 ± 0.5 | 178 ± 2 | 3000 |

7.Storage and Transportation Information

Storage Conditions

To maintain the solderability of terminal electrodes:

1. Temperature and humidity conditions: -10~ 40℃ and 30~70% RH.
2. Recommended products should be used within 6 months from the time of delivery.
3. The packaging material should be kept where no chlorine or sulfur exists in the air.

Transportation Conditions

1. Products should be handled with care to avoid damage or contamination from perspiration and skin oils.
2. The use of tweezers or vacuum pick up is strongly recommended for individual components.
3. Bulk handling should ensure that abrasion and mechanical shock are minimized.